



GSX11N65M

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

Super Junction MOSFET

650V Super Junction Power Transistor

GSX11N65M

Data Sheet

Ver 0

2019-3-20

650V 11A Power MOSFET

■ Description

GroupSemiconductor(GS) has series Multi-EPI Super-Junction power MOSFET platforms for voltage up 500V to 1000 volts, both with design service and manufacturing capability, including cell, termination design and simulation.

The GS 650V 11A power MOSFET is a Low voltage N channel Multi-EPI Super-Junction power MOSFET sample with advanced technology to have better characteristics, such as fast switching time, low Ciss and Crss, low on resistance and excellent avalanche characteristics, making it especially suitable for applications which require superior power density and outstanding efficiency.

■ Features

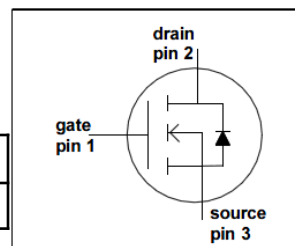
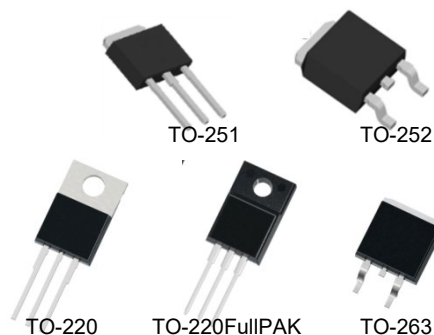
$R_{DS(ON)}=0.42\Omega$ @ $V_{GS} = 10V$

$V_{DS} = 650V$

I_D (@ $V_{GS}=10V$) = 6.5A

■ PKG

GSA11N65M	GSP11N65M	GSB11N65M	GSD11N65M	GSS11N65M
TO-220Fullpak	TO-220	TO-263	TO-252	TO-251



■ Absolute Maximum Ratings (TC = 25° C, unless otherwise specified)

Symbol	Parameter	GSP11N65M	GSA11N65M	Unit
V_{DSS}	Drain-Source Voltage	650		V
I_D	Drain Current -Continuous (TC = 25°C) -Continuous (TC = 100°C)	11* 7*		A
I_{DM}	Drain Current - Pulsed (Note 1)	42		A
V_{GSS}	Gate-Source voltage	± 30		V
E_{AS}	Single Pulsed Avalanche Energy (Note 2)	260		mJ
I_{AR}	Avalanche Current (Note 1)	2		A
E_{AR}	Repetitive Avalanche Energy (Note 1)	1		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	15		V/ns
dV_{ds}/dt	Drain Source voltage slope (V _{ds} =480V)	50		V/ns
P_D	Power Dissipation (TC = 25°C)	151	35	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150		°C
T_L	Max. Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds	300		°C

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■ Thermal Characteristics

Symbol	Parameter	GSA11N65M	GSP11N65M	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.2	1.2	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62	62	°C/W

Symbol	Parameter	Value (TO220)	Unit
$R_{\theta JA}^{(6)}$	Maximum Junction-to-Ambient	82	°C/W
$R_{\theta CS}^{(6)}$	Maximum Case-to-sink	0.6	°C/W
$R_{\theta JC}^{(7),(8)}$	Maximum Junction-to-Case θ	4.1	°C/W

1. The power dissipation PD is based on $T_J(\text{MAX})=150^\circ\text{C}$ in a TO251 package, using junction-to-case thermal resistance.
2. Repetitive rating, pulse width limited by junction temperature $T_J(\text{MAX})=150^\circ\text{C}$.
3. $L=1\text{mH}$, Starting $T_J=25^\circ\text{C}$.
4. $L=10\text{mH}$, starting $T_J=25^\circ\text{C}$.
5. $L=60\text{mH}$, starting $T_J=25^\circ\text{C}$.
6. The tests are performed with the device with $T_A=25^\circ\text{C}$.
7. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
8. These curves are based on the junction-to-case thermal impedance, assuming a maximum junction temperature of $T_J(\text{MAX})=150^\circ\text{C}$.

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■ Electrical Characteristics (T_J=25° C unless otherwise specified)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA, T _J = 25°C	650	--	--	V
		V _{GS} = 0V, I _D = 250μA, T _J = 150°C	--	700	--	V
ΔBV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	--	0.6	--	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 650V, V _{GS} = 0V -T _J = 150°C	--	-- 10	1 -	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30V, V _{DS} = 0V	--	--	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30V, V _{DS} = 0V	--	--	-100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	2.5	--	4.5	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 5.5A	--	0.38	0.42	Ω
g _{FS}	Forward Transconductance	V _{DS} = 40V, I _D = 5.5A	--	16	--	S
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 25V, V _{GS} = 0V, f = 1.0MHz	--	720	-	pF
C _{oss}	Output Capacitance		--	20	-	pF
C _{rss}	Reverse Transfer Capacitance		--	1.5	--	pF
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} = 400V, I _D = 5.5A R _G = 20Ω (Note 4)	--	15	--	ns
t _r	Turn-On Rise Time		--	10	--	ns
t _{d(off)}	Turn-Off Delay Time		--	110	--	ns
t _f	Turn-Off Fall Time		--	9	--	ns
Q _g	Total Gate Charge	V _{DS} = 400V, I _D = 5.5A V _{GS} = 10V (Note 4)	--	32	--	nC
Q _{gs}	Gate-Source Charge		--	4	--	nC
Q _{gd}	Gate-Drain Charge		--	16	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current		--	--	9.2	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	30	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 5.5A	--	0.9	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 5.5A	--	280	--	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100A/μs	--	3.3	--	μC

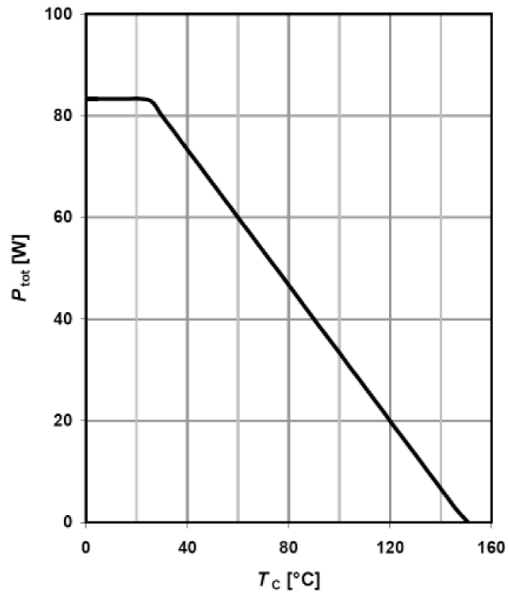
NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. L=60mH, I_{AS}=3A, V_{DD}=150V, Starting T_J=25 °C
3. I_{SD}≤4.5A, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25 °C
4. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 2%
5. Essentially Independent of Operating Temperature Typical Characteristics

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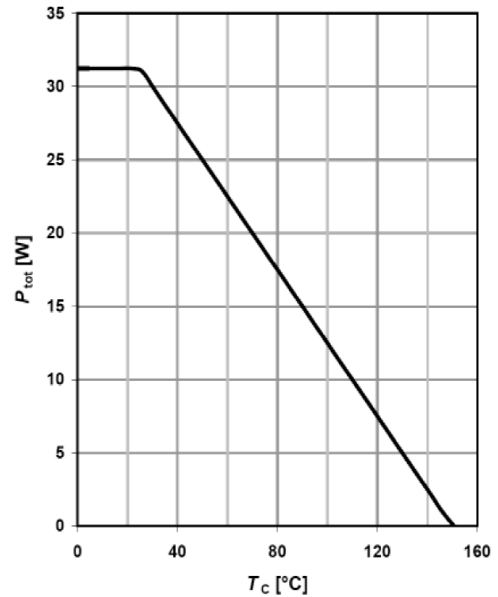
Typical Performance Characteristics

Power dissipation
TO-220, TO-247, TO-3P



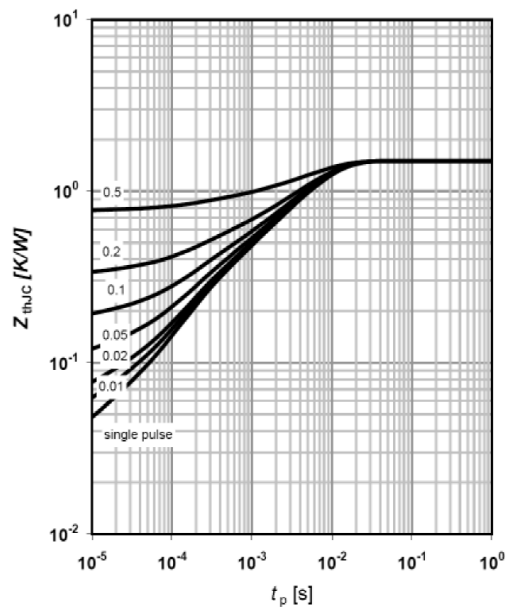
$$P_{tot} = f(T_c)$$

Power dissipation
TO-220F



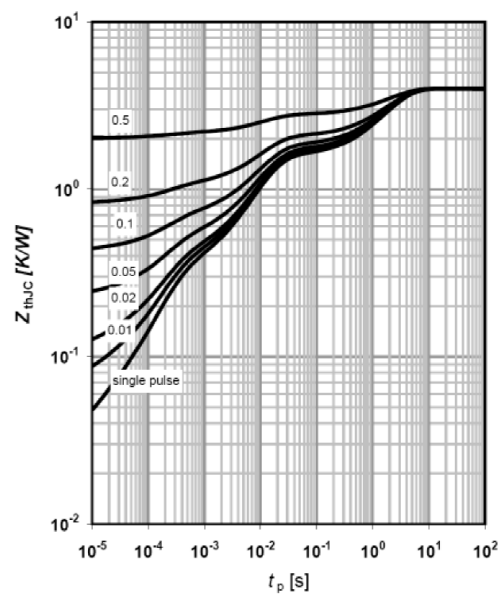
$$P_{tot} = f(T_c)$$

Max. transient thermal impedance
TO-220, TO-247, TO-3P



$$Z_{(thJC)} = f(t_p); \text{ parameter: } D = t_p/T$$

Max. transient thermal impedance
TO-220F



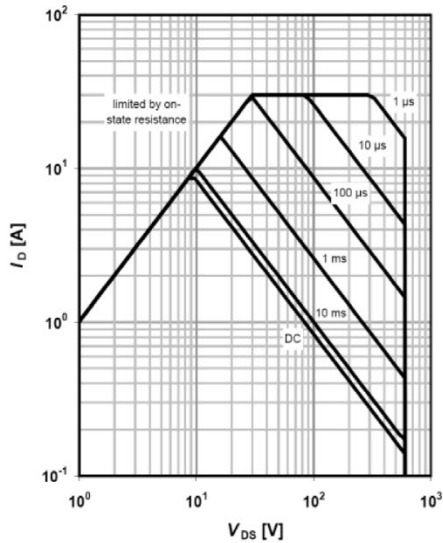
$$Z_{(thJC)} = f(t_p); \text{ parameter: } D = t_p/T$$

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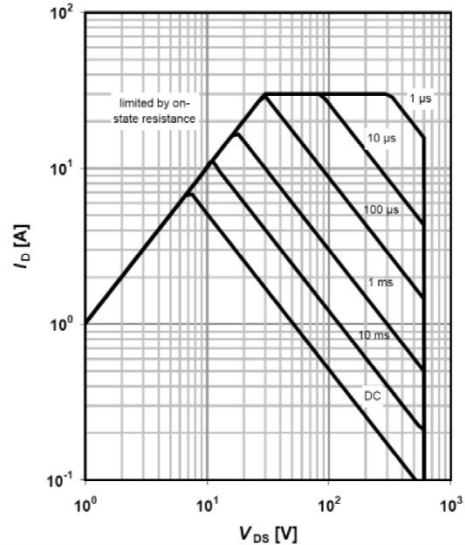
Typical Performance Characteristics

Safe operating area $T_C=25\text{ }^{\circ}\text{C}$
TO-220, TO-247, TO-3P

Safe operating area $T_C=25\text{ }^{\circ}\text{C}$
TO-220F



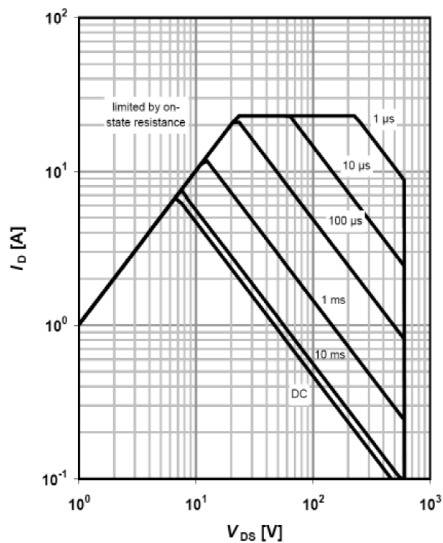
$I_D=f(V_{DS})$; $T_C=25\text{ }^{\circ}\text{C}$; $D=0$; parameter t_p



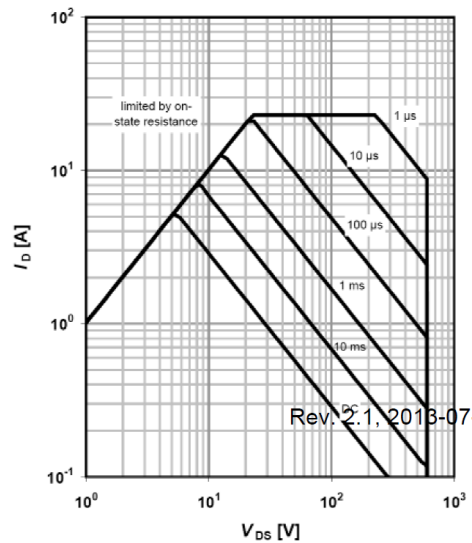
$I_D=f(V_{DS})$; $T_C=25\text{ }^{\circ}\text{C}$; $D=0$; parameter t_p

Safe operating area $T_C=80\text{ }^{\circ}\text{C}$
TO-220, TO-247, TO-3P

Safe operating area $T_C=80\text{ }^{\circ}\text{C}$
TO-220F



$I_D=f(V_{DS})$; $T_C=80\text{ }^{\circ}\text{C}$; $D=0$; parameter t_p



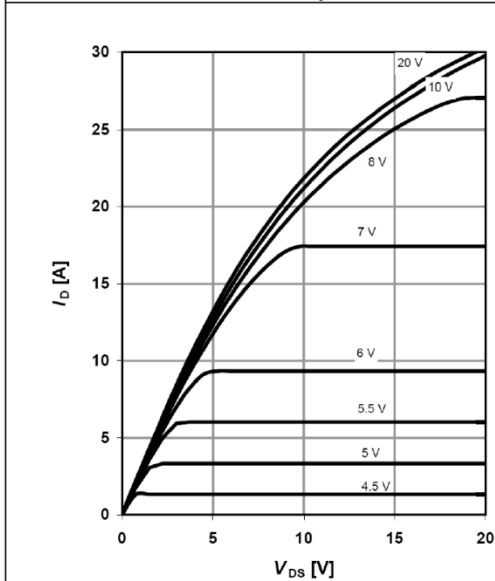
$I_D=f(V_{DS})$; $T_C=80\text{ }^{\circ}\text{C}$; $D=0$; parameter t_p

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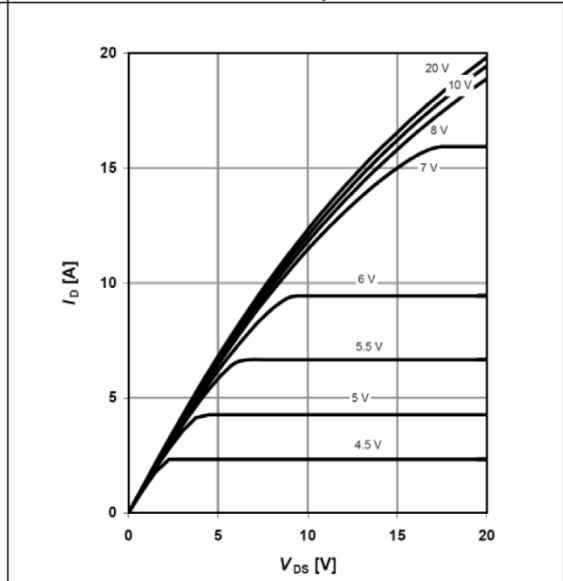
Typical Performance Characteristics

Typ. output characteristics $T_j=25\text{ }^{\circ}\text{C}$



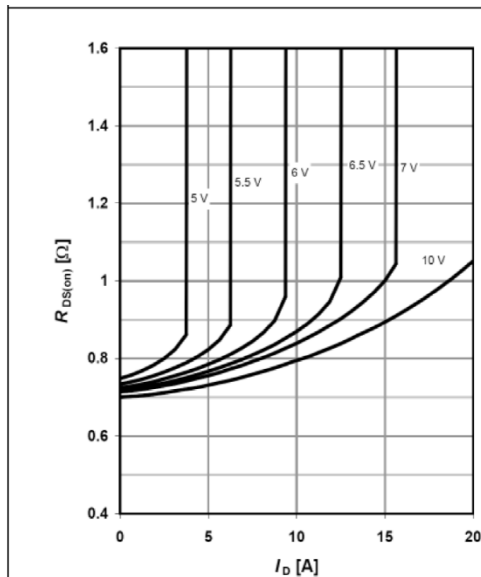
$$I_D = f(V_{DS}); T_j = 25\text{ }^{\circ}\text{C}; \text{parameter: } V_{GS}$$

Typ. output characteristics $T_j=125\text{ }^{\circ}\text{C}$



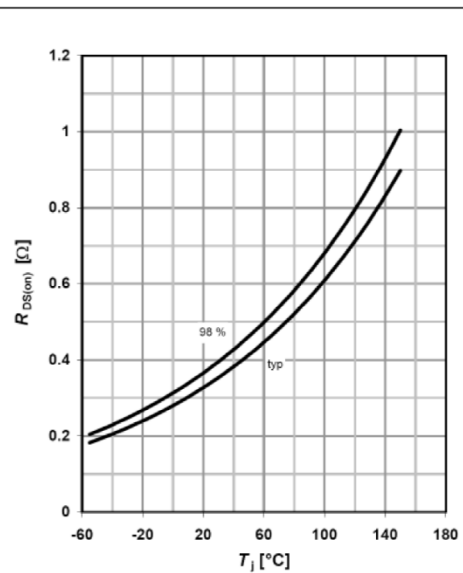
$$I_D = f(V_{DS}); T_j = 125\text{ }^{\circ}\text{C}; \text{parameter: } V_{GS}$$

Typ. drain-source on-state resistance



$$R_{DS(on)} = f(I_D); T_j = 125\text{ }^{\circ}\text{C}; \text{parameter: } V_{GS}$$

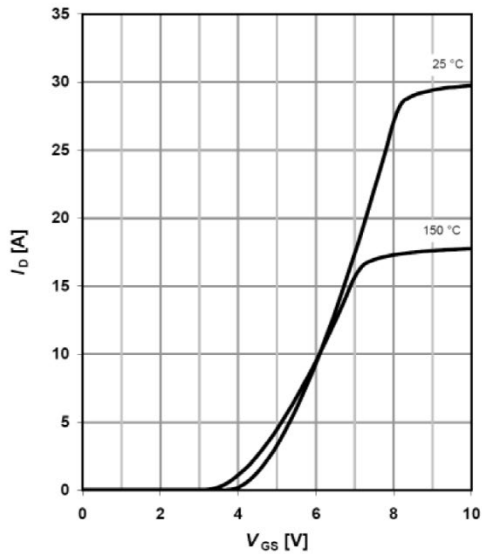
Typ. drain-source on-state resistance



$$R_{DS(on)} = f(T_j); I_D = 3.8\text{ A}; V_{GS} = 10\text{ V}$$

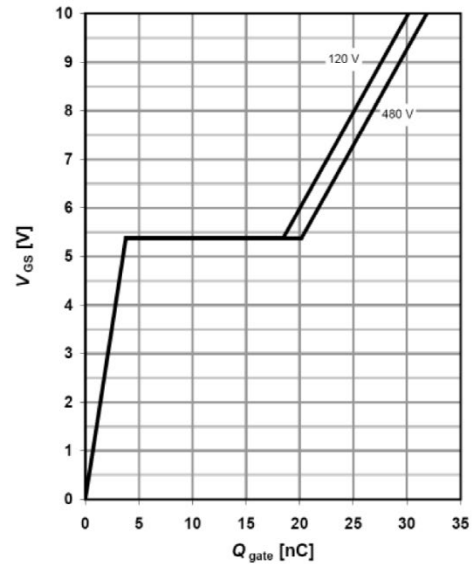
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Typ. transfer characteristics



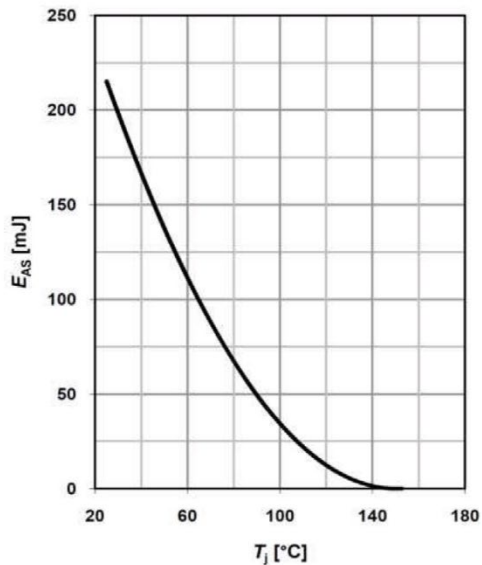
$$I_D = f(V_{GS}); V_{DS} = 20V$$

Typ. gate charge



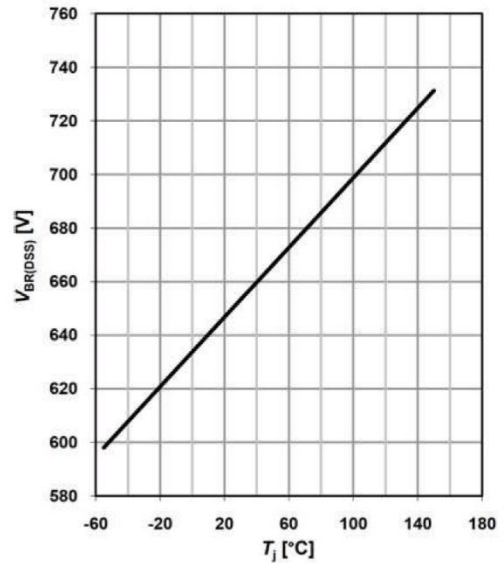
$$V_{GS} = f(Q_{gate}), I_D = 4.8A \text{ pulsed}$$

Avalanche energy



$$E_{AS} = f(T_J); I_D = 1.8A; V_{DD} = 50V$$

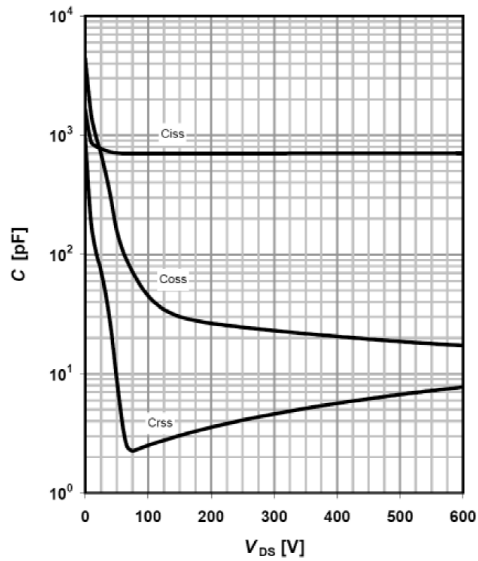
Drain-source breakdown voltage



$$V_{BR(DSS)} = f(T_J); I_D = 1.0mA$$

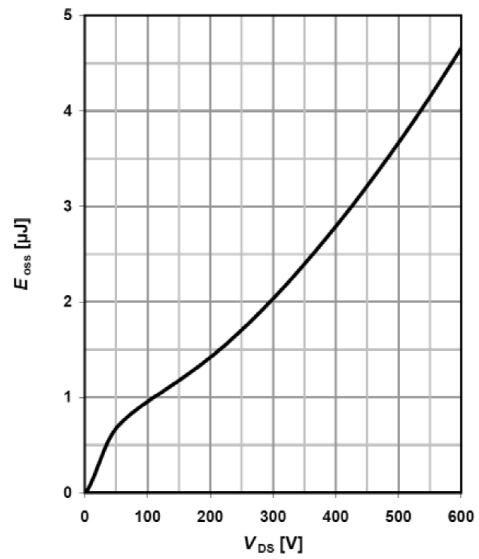
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Typ. capacitances



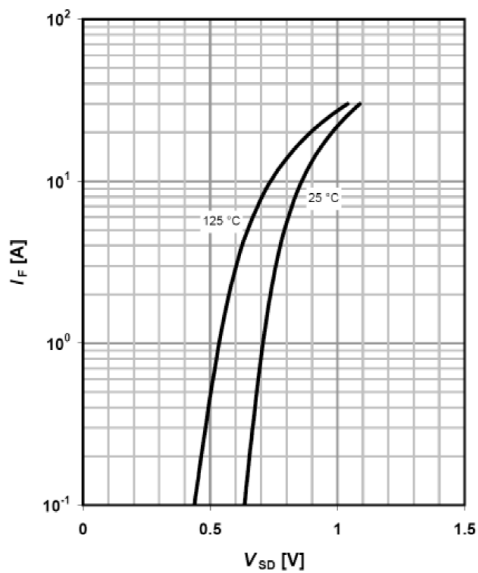
$$C=f(V_{DS}); V_{GS}=0 \text{ V}; f=1 \text{ MHz}$$

Typ. C_{oss} stored energy



$$E_{oss}=f(V_{DS})$$

Forward characteristics of reverse diode



$$I_F=f(V_{SD}); \text{ parameter: } T_j$$

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Table 20 Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load	Switching time waveform
The diagram shows a MOSFET switching circuit. A pulse source is connected to the gate through a resistor. The MOSFET's drain is connected to an inductor, which is in series with a load. A freewheeling diode is connected in parallel with the inductor. The drain voltage is labeled V_{DS} and the gate voltage is labeled V_{GS}.	The diagram shows the switching waveforms for V_{DS} and V_{GS}. The V_{GS} waveform is a square wave. The V_{DS} waveform shows the voltage across the MOSFET during switching. Key time intervals are marked: $t_{d(on)}$ (delay to turn on), t_r (rise time), t_{on} (total turn-on time), t_{off} (total turn-off time), t_f (fall time), and $t_{d(off)}$ (delay to turn off). The V_{DS} waveform also shows the 10% and 90% voltage levels during the transitions.

Table 21 Unclamped inductive load test circuit and waveform

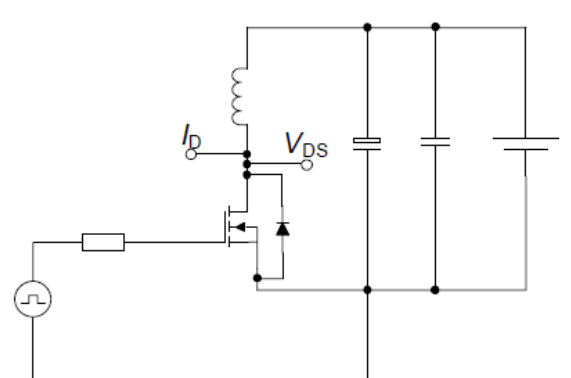
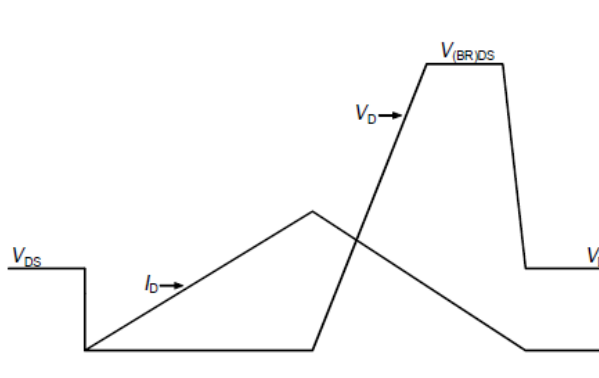
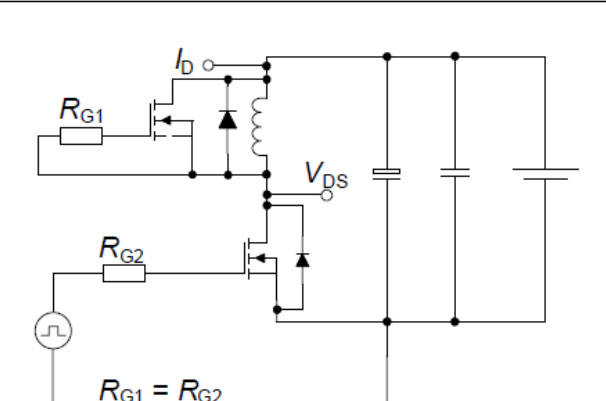
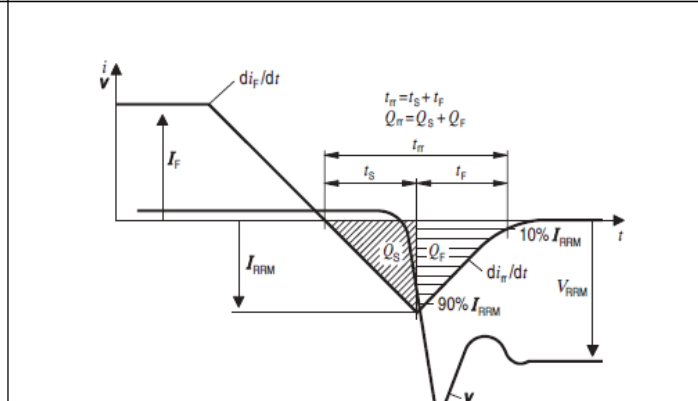
Unclamped inductive load test circuit	Unclamped inductive waveform
	

Table 22 Test circuit and waveform for diode characteristics

Test circuit for diode characteristics  $R_{G1} = R_{G2}$	Diode recovery waveform  $t_n = t_S + t_F$ $Q_n = Q_S + Q_F$ $10\% I_{FRM}$ $90\% I_{FRM}$ V_{FRM} SIL00088
---	--